Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/719,758	LEE ET AL.
Examiner	Art Unit
David Buttner	1712

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
525	all	2/20/2007	DB		
264	all	2/20/2007	DB		
		9			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
east		2/20/2007	DB	
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